S G_S-THOMSON 2-CHANNEL FLOPPY DISK READ/ WRITE CIRCUITS

7929237 0022178 4

TWO GAIN VERSIONS (A AND B)

30E D

COMPATIBLE WITH 8", 5.25" AND 3.5" DRIVES.

SGS-THOMSON

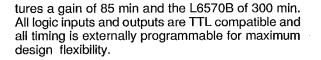
MICROELECTRONICS

- INTERNAL WRITE AND ERASE CURRENT SOURCES, EXTERNALLY SET
- INTERNAL CENTER TAP VOLTAGE SOURCE
- CONTROL SIGNALS ARE TTL COMPATIBLE
- TTL SELECTABLE WRITE CURRENT BOOST
- OPERATES ON + 12 V AND + 5 V POWER SUP-PLIES

DESCRIPTION

The L6570A/ B are integrated circuits which perform the functions of generating write signals and amplifying and processing read signals required for a double sided floppy disk drive. The L6570A fea-

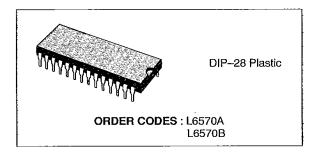
BLOCK DIAGRAM

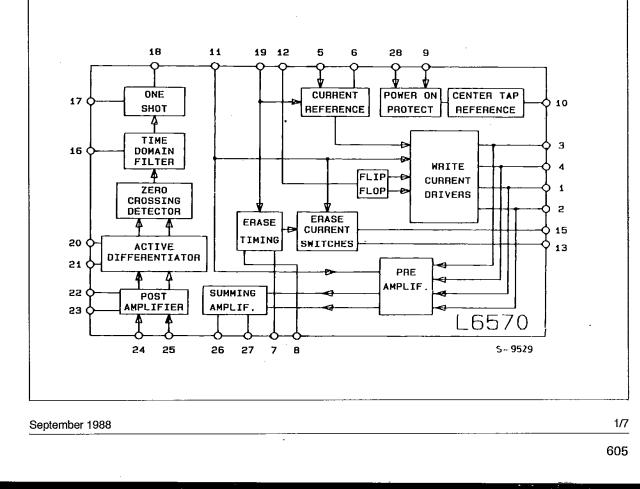


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L6570A

L6570B





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■ <u>4 P715500 765P2P7</u> ■ 4 30E

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Symbol	Parameter	Test Conditions	Unit
V _{CC} 5V Supply Voltage	5V Supply Voltage	7	V
V _{DD}	12V Supply Voltage	- 14	V
T _{stg}	Storage Temperature	- 65 to 150	℃
T _{amb}	Ambient Operating Temperature	0 to + 70	0°
Tj.	Junction Operating Temperature	0 to + 130	°C
Vr	Logic Input Voltage	- 0.5 to 7.0	V
Ptot	Power Dissipation	500	mW

CONNECTION DIAGRAM (top view)

		+HD1 3 -HD1 4 CB 5 Rw 6 ReCe 7 Re 8 Vdd 9 Vct 10 HS0/HS1 11 VDI 12 E1 13 GND 14	24 23 22 21 20 19 16 16 15	62 D1 D2 R/W RDP PW TD			
			5-9528				
							·
	istance Junction	u-amblent		Max	100		°C/V
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	30E	D _		7929237	0055790	2		L6570A-L6570B
			2	G S-THOM	SON.	_	52-38	
ELEC	TRICAL	CH	ARAC	TERISTICS (unl	ess otherwise sp	ecitie	ea, 4.75V \leq V _C	$_{\rm C} \le 5.25 \text{V}$; 11.4 $\text{V} \le \text{V}_{\rm DD}$
≤ 12,6	SV;0℃:	≤ T _{am} i	o ≤ 70	℃; R _W = 430 Ω	$R_{ED} = 62 \text{ K}\Omega$; C _E	= 0.012 μF;R	$E_{\rm EH} = 62 \ {\rm K}\Omega$; ${\rm R}_{\rm EC}$

=220Ω)

Symbol	Parameter	Test Condiions	Min.	Тур.	Max.	Unit

POWER SUPPLY CURRENTS

loc	5V Supply Current	Read Mode Write Mode	35 38	mA mA
loo	12V Supply Current	Read Mode L6570A L6570B	26 35	mA mA
		Write Mode (exclude Write and Erase currents) L6570A L6570B	24 35	mA mA

LOGIC SIGNALS-READ/WRITE (R/W), CURRENT BOOST (CB)

ViL	Input Low Voltage			0.8	V
l î∟	Input Low Current	V _{IL} = 0.4V		- 0.4	mA
V _{IH}	Input High Voltage		2.0		V
lικ	Input High Current	V _{IH} = 2.4V		20	μA

LOGIC SIGNALS-WRITE DATA INPUT (WDI), HEAD SELECT (HS0/HS1)

-	V _T +	Threshold Voltage, Positive-going		1.4	1.9	V
	V _T -	Threshold Voltage, Negative-going		0.6	1.1	V
	V_T+, V_T-	Hysteresis		0.4		V
	l _{IH} .	Input High Current	V _{IH} = 2.4V		20	μA
÷	۱ _{۱۲}	Input Low Current	V _{IL} = 0.4V		- 0.4	mA

CENTER TAP VOLTAGE REFERENCE

V _{CT}	Output Voltage	I _{WC} + I _E = 3 mA to 60 mA	V _{DD} -1.5	V _{DD} -0.5	v
Vcc	Turn-Off Threshold		4.0		V
V _{DD}	Turn-Off Threshold		9.6		V
Vct	Disabled Voltage			1.0	V

ERASE OUTPUTS (E1, E0)

		Unselected Head Leakage	V _{EO} , V _{E1} = 12.6V		100	μA
V_{E1}	, V _{eo}	Output on Voltage	l _E = 50 mA		0.5	V



3/7

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L6570A	-L657 30E D_	7929237 002	2181 L			
ELECTR		G S-THOMSON (Continued)	(۲!	52-38	-
Symbol	Parameter.	Test Conditions	Min.	Тур.	Max.	Uni
WRITE	CURRENT					
	Unselected Head Leakage	$V_{E1}, V_{E0} = 12.6V$			25	μA
	Write Current Range	R _W = 820 Ω to180 Ω	3		10	mA
	Current Reference Accuracy	I _{W C} = 2.3/R _W V _{CB} (current boost) = 0.5V	5		+5	%
	Write Current Unbalanced	I _{W C} = 3 mA to 10 mA			1.0	.%
	Differential Head Voltage Swing	$\Delta I_{WC} \le 5 \%$	12.8			, Vp
	Current Boost	V _{CB} = 2.4V	1.25 Iwc		1.35 Iwc	
BASE	TIMING	· · · · · · · · · · · · · · · · · · ·				
			- <u></u>			
	Erase Delay Range	$R_{ED} = 39 \text{ K}\Omega \text{ to } 82 \text{ K}\Omega$ $C_E = 0.0015 \text{ μF to } 0.043 \text{ μF}$	0.1		1.0	ms
	Erase Delay Accuracy	$T_{ED} = 0.69 R_{ED} C_{E}$	- 15		+ 15	%

$\frac{\Delta T_{ED}}{T_{ED}} \times 100 \%$	$R_{ED} = 39 \text{ K}\Omega \text{ to } 82 \text{ K}\Omega$ $C_E = 0.0015 \mu\text{F} \text{ to } 0.043 \mu\text{F}$		1 10	
Erase Hold Range	R_{EH} + R_{ED} = 78 KΩ to 164 KΩ C_E = 0.0015 μF to 0.043 μF	0.2	2.0	· ms
Erase Hold Accuracy ΔT_{ED} T_{ED} x 100 %	$T_{EH} = 0.69$ (R _{ED} + R _{ED}) C _E R _{EH} + R _{ED} = 78 KΩ to 164 KΩ C _E = 0.0015 μF to 0.043 μF	- 15	+ 15	%

ELECTRICAL CHARACTERISTICS (Unless otherwise specified : V_{IN} (Preamplifier) =10mV_{pp} sine wave, DC coupled to center tap. Summing amplifier load = 2 K Ω line-line, AC coupled. V_{IN} (Postamplifier)= 0.2 V_{pp} sine wave, AC coupled ; R_G = open ; Data pulse load = 1 K Ω to V_{CC} ; C_D = 240 pF ; C_{TD} = 100 pF ; R_{TD} = 7.5 K Ω ; C_{PW} = 47 pF ; R_{PW} = 7.5 K Ω).

READ MODE

	Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
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PREAMPLIFIER-SUMMING AMPLIFIER

Diff Voltage Gain	Freq. = 250 KHz L6570A L6570B		115 400	V/V
Bandwidth (- 3 dB)		3		MHz
Gain Flatness	Freq. = DC to 1.5 MHz		± 1.0	dB
 Diff. Input Impedance	Freq. = 250 KHz	20		KΩ
Max. Diff. Output Voltage Swing	V _{IN} = 250 KHz Sine Wave THD ≤ 5 % L6570A L6570B	2.5 4.0	τ ·····	V _{pp}
Small Signal Difference Output Resistance	$I_O \leq 1.0 \text{ mA}_{pp}$		75	Ω
Common Mode Rejection Ratio	V _{IN} = 300 mV _{pp} @ 500 KHz Inputs Shorted L6570A L6570B	50 40		dB

SGS-THOMSON MICROELECTRONICS

4/7

608

G AMPL	$\Delta V_{DD} = 300 \text{ mV}_{pp} @ 500 \text{ KHz}$ Inputs Shorted to V _{CT} Unselected Channel V _{IN} =100 mV _{pp} @ 500 KHz. Selected Channel Input Connected to V _{CT} Power BW = 10 kHz to 1 MHz Inputs Shorted to V _{CT} EENTIATOR Freq. = 250 KHz C _D = 0.1 μ F, R _D = 2.5 KΩ Freq. = DC to 1.5 MHz C _D = 0.1 μ F, R _D = 2.5 KΩ	Min. 50 40 8.5 3	Typ.	Max.	dΒ μVrn V
ion Ratio se E DIFFER in	$\Delta V_{DD} = 300 \text{ mV}_{pp} @ 500 \text{ KHz}$ Inputs Shorted to V _{CT} Unselected Channel V _{IN} =100 mV _{pp} @ 500 KHz. Selected Channel Input Connected to V _{CT} Power BW = 10 kHz to 1 MHz Inputs Shorted to V _{CT} EENTIATOR Freq. = 250 KHz C _D = 0.1 μ F, R _D = 2.5 KΩ Freq. = DC to 1.5 MHz C _D = 0.1 μ F, R _D = 2.5 KΩ	40	1.5		dB dB μV_{rn} V
ion Ratio se E DIFFER in	$\Delta V_{DD} = 300 \text{ mV}_{pp} @ 500 \text{ KHz}$ Inputs Shorted to V _{CT} Unselected Channel V _{IN} =100 mV _{pp} @ 500 KHz. Selected Channel Input Connected to V _{CT} Power BW = 10 kHz to 1 MHz Inputs Shorted to V _{CT} EENTIATOR Freq. = 250 KHz C _D = 0.1 μ F, R _D = 2.5 KΩ Freq. = DC to 1.5 MHz C _D = 0.1 μ F, R _D = 2.5 KΩ	40	1.5		dΒ μVrn V
se E DIFFER in	Unselected Channel $V_{IN} = 100 \text{ mV}_{pp}$ @ 500 KHz. Selected Channel Input Connected to V_{CT} Power BW = 10 kHz to 1 MHz Inputs Shorted to V_{CT} RENTIATOR Freq. = 250 KHz $C_D = 0.1 \mu F, R_D = 2.5 K\Omega$ Freq. = DC to 1.5 MHz $C_D = 0.1 \mu F, R_D = 2.5 K\Omega$	8.5	1.5		μV _{rn} V
E DIFFER	Inputs Shorted to V_{CT} EENTIATOR Freq. = 250 KHz $C_D = 0.1 \mu F, R_D = 2.5 K\Omega$ Freq. = DC to 1.5 MHz $C_D = 0.1 \mu F, R_D = 2.5 K\Omega$		1.5		v
Itage	Freq. = 250 KHz $C_D = 0.1 \mu F$, $R_D = 2.5 K\Omega$ Freq. = DC to 1.5 MHz $C_D = 0.1 \mu F$, $R_D = 2.5 K\Omega$		1.5	11.5	<u> </u>
Itage	Freq. = 250 KHz $C_D = 0.1 \mu F$, $R_D = 2.5 K\Omega$ Freq. = DC to 1.5 MHz $C_D = 0.1 \mu F$, $R_D = 2.5 K\Omega$			11.5	
Itage	Freq. = 250 KHz $C_D = 0.1 \mu F$, $R_D = 2.5 K\Omega$ Freq. = DC to 1.5 MHz $C_D = 0.1 \mu F$, $R_D = 2.5 K\Omega$			11.5	
Itage	Freq. = DC to 1.5 MHz C _D = 0.1 μ F, R _D = 2.5 K Ω	3		۰ F	
Itage	$C_{D} = 0.1 \ \mu F, R_{D} = 2.5 \ K\Omega$				MH
				± 1.0	dB
	$V_{IN} = 250 \text{ KHz Sine Wave, AC}$ Coupled. $\leq 5 \% \text{ THD in Voltage across C}_D$	5.0			V _{pp}
ıge	$V_{IN} = 250 \text{ KHz}$ Sine Wave, AC Coupled. $\leq 5 \%$ THD in Voltage across C_D , $R_G = 1.5 \text{ K}\Omega$	2.5			V _{pp}
e		10		 	ΚΩ
		- 25		+ 25	%
	amp. that results in a change of state at RDP $V_{IN} = 250 \text{ KHz}$ square wave, $C_D = 0.1 \ \mu \text{F}$ R $_D = 500 \ \Omega$, T_R , $T_F \le 0.2 \ \mu \text{s}$. No overshoot ; Data pulse from each V_{IN}			3.7	mV _P
work		1.0			mA
	ə y I Input	$\begin{array}{llllllllllllllllllllllllllllllllllll$	$\begin{array}{c c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

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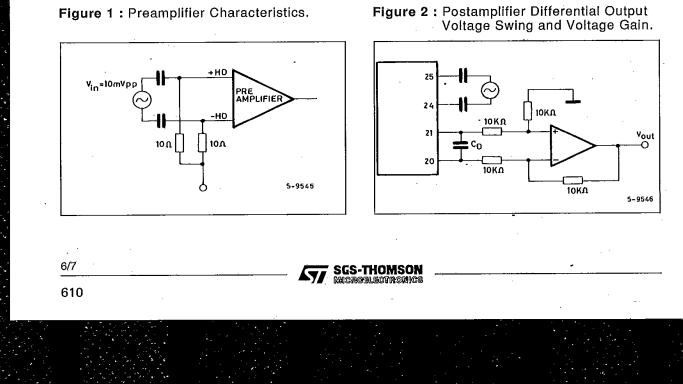
ELECTR	ICAL CHARACTERIST	ICS (Continued)		T-52	-38	
Symbol	Parameter	Test Conditions	Mín.	Тур.	Max.	Uni
	OMAIN FILTER		-			·
· · ·	Delay Accuracy ΔT _{TD} T _{TD} x 100 %	$\begin{array}{l} T_{TD} = 0.58 \ \text{R}_{TD} \cdot (\text{C}_{TD} + 10^{-11}) + \\ 150 \ \text{ns.} \\ \text{R}_{TD} = 5 \ \text{K}\Omega \ \text{to} \ 10 \ \text{K}\Omega \\ \text{C}_{TD} = 56 \ \text{pF} \\ \text{V}_{\text{IN}} = 50 \ \text{mV}_{\text{pp}} @ \ 250 \ \text{KHz sq.} \\ \text{wave} \\ \text{T}_{\text{R}}, \ \text{T}_{\text{F}} \leq 20 \ \text{ns.} \ \text{AC coupled.} \\ \text{Delay measured from 50 \% input} \\ \text{amplitude to} \ 1.5 \ \text{V} \ \text{data pulse} \end{array}$	- 15		+ 15	%
	Delay Range	$T_{TD} = 0.58 R_{TD} = (C_{TC} + 10^{-11}) + 150 ns.$ $R_{TD} = 5 K\Omega \text{ to } 10 K\Omega$ $C_{TD} = 56 \text{ pF to } 240 \text{ pF}$ $R_D = 500 \Omega$ $C_D = 0.1 \mu\text{F}.$	240		2370	ns

DATA PULSE

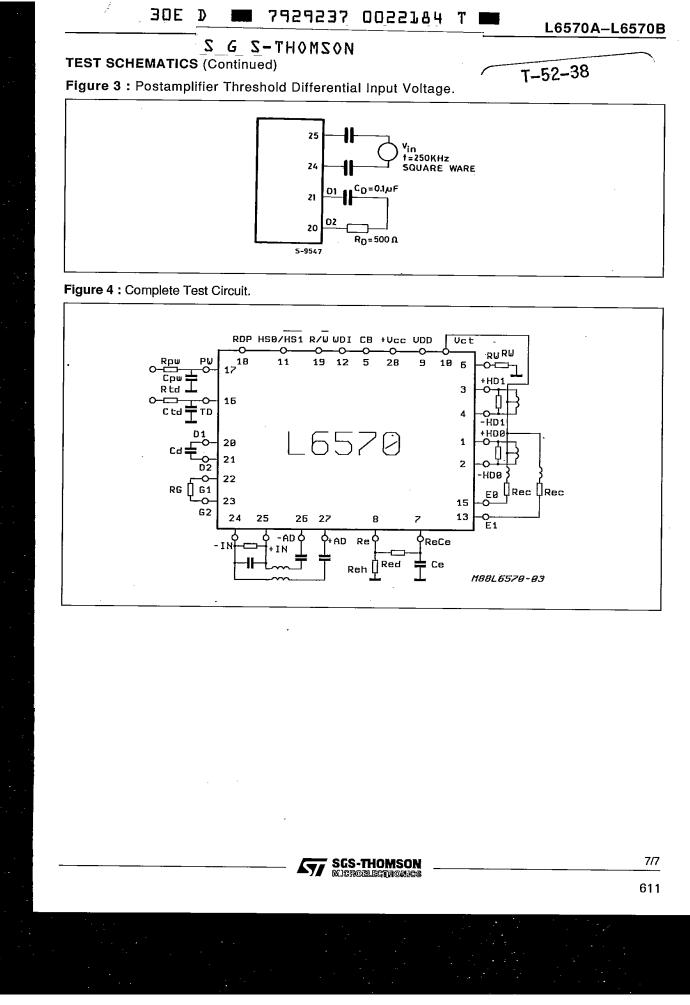
Width Accuracy <u> </u>	$\begin{array}{l} T_{PW} \simeq 0.58 \ \text{R}_{PW} \ x \ (\text{C}_{PW} + 8 \\ x \ 10^{-12}) \ + \ 20 \ \text{ns} \\ \text{R}_{PW} = 5 \ \text{K}\Omega \ \text{to} \ 10 \ \text{K}\Omega \\ \text{C}_{PW} \ge 36 \ \text{pF} \\ \text{with measured at} \ 1.5 \text{V} \ \text{amplitudes} \end{array}$	- 20	+ 20	%
Active Level Output Voltage	l _{oн} = 400 μA	2.7		V
Inactive Level Output Leakage	I _{OL} = 4 mA	-	0.5	V
Pulse Width	$T_{PW} = 0.58 R_{PW} \times (C_{PW} + 8 \times 10^{-12}) + 20 ns$ $R_{PW} = 5 K\Omega$ to 10 KΩ $C_{PW} = 36 pF$ to 200 pF	145	1225	ns

TEST SCHEMATICS

Figure 1 : Preamplifier Characteristics.



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